



NSAI
Standards

Irish Standard
I.S. EN IEC 60749-26:2018

Semiconductor devices - Mechanical and climatic test methods - Part 26: Electrostatic discharge (ESD) sensitivity testing - Human body model (HBM)

I.S. EN IEC 60749-26:2018

Incorporating amendments/corrigenda/National Annexes issued since publication:

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National Foreword

I.S. EN IEC 60749-26:2018 is the adopted Irish version of the European Document EN IEC 60749-26:2018, Semiconductor devices - Mechanical and climatic test methods - Part 26: Electrostatic discharge (ESD) sensitivity testing - Human body model (HBM)

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EUROPEAN STANDARD

EN IEC 60749-26

NORME EUROPÉENNE

EUROPÄISCHE NORM

March 2018

ICS 31.080.01

Supersedes EN 60749-26:2014

English Version

**Semiconductor devices - Mechanical and climatic test methods -
Part 26: Electrostatic discharge (ESD) sensitivity testing -
Human body model (HBM)
(IEC 60749-26:2018)**

Dispositifs à semiconducteurs - Méthodes d'essais
mécaniques et climatiques - Partie 26: Essai de sensibilité
aux décharges électrostatiques (DES) - Modèle du corps
humain (HBM)
(IEC 60749-26:2018)

Halbleiterbauelemente - Mechanische und klimatische
Prüfverfahren - Teil 26: Prüfung der Empfindlichkeit gegen
elektrostatische Entladungen (ESD) - Human Body Model
(HBM)
(IEC 60749-26:2018)

This European Standard was approved by CENELEC on 2018-02-19. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration.

Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the CEN-CENELEC Management Centre or to any CENELEC member.

This European Standard exists in three official versions (English, French, German). A version in any other language made by translation under the responsibility of a CENELEC member into its own language and notified to the CEN-CENELEC Management Centre has the same status as the official versions.

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European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

CEN-CENELEC Management Centre: Rue de la Science 23, B-1040 Brussels

EN IEC 60749-26:2018 (E)

European foreword

The text of document 47/2438/FDIS, future edition 4 of IEC 60749-26, prepared by IEC/TC 47 "Semiconductor devices" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN IEC 60749-26:2018.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2018-11-19
- latest date by which the national standards conflicting with the document have to be withdrawn (dow) 2021-02-19

This document supersedes EN 60749-26:2014.

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Endorsement notice

The text of the International Standard IEC 60749-26:2018 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

IEC 60749 (series)	NOTE	Harmonized as EN 60749 (series).
IEC 60749-27	NOTE	Harmonized as EN 60749-27.

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